Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	r
10/539,731	LEE ET AL.	
Examiner	Art Unit	
Sai-Ming Chan	2616	

SEARCHED				
Class	Subclass	Date	Examiner	
370	352	12/11/2007	sc	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST Image and keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (see attached search strategy)	12/11/2007	SC
Inventor name and Assignee search in PALM EXPO and EAST	12/11/2007	sc
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